

# FDZ7064AS

## 30V N-Channel PowerTrench® SyncFET™ BGA MOSFET

### Features

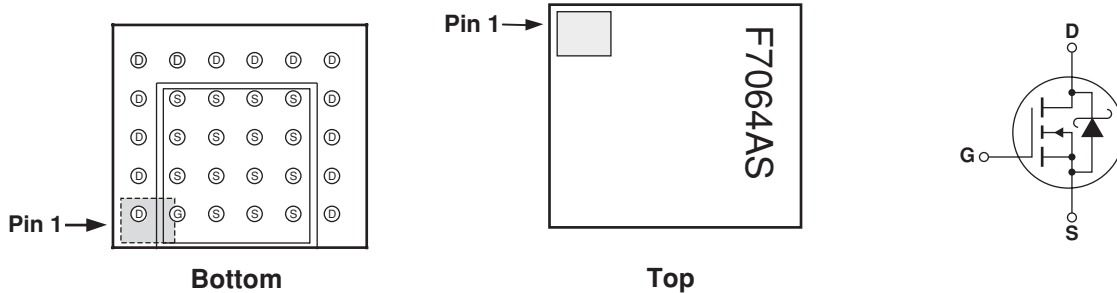
- 13.5 A, 30 V.  $R_{DS(ON)} = 5.6 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$   
 $R_{DS(ON)} = 7.1 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Occupies only 14 mm<sup>2</sup> of PCB area. Only 42% of the area of SO-8
- Ultra-thin package: less than 0.76 mm height when mounted to PCB
- 3.5 x 4 mm<sup>2</sup> Footprint
- High power and current handling capability.

### Applications

- DC/DC converters

### General Description

This MOSFET is designed to replace a single MOSFET and parallel Schottky diode in synchronous DC:DC power supplies. Combining Fairchild's 30V PowerTrench SyncFET process with state of the art BGA packaging, the FDZ7064AS minimizes both PCB space and  $R_{DS(ON)}$ . This BGA SyncFET embodies a breakthrough in both packaging and power MOSFET integration which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, ultra-low reverse recovery charge and low  $R_{DS(ON)}$ .



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain-Source Voltage	30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current	- Continuous (Note 1a)	13.5
		- Pulsed	60
$P_D$	Power Dissipation (Steady State) (Note 1a)	2.2	W
$T_J, T_{stg}$	Operating and Storage Junction Temperature Range	$-55$ to $+150$	$^\circ\text{C}$

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	56	$^\circ\text{C/W}$
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball (Note 1)	4.5	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	0.6	

### Package Marking and Ordering Information

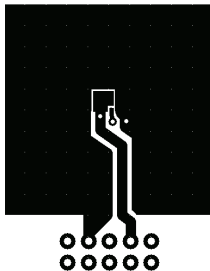
Device Marking	Device	Reel Size	Tape width	Quantity
7064AS	FDZ7064AS	13"	12mm	3000

**Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise noted

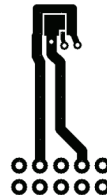
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain–Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 10\text{ mA}$ , Referenced to $25^\circ\text{C}$		25		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$			500	$\mu\text{A}$
$I_{GSS}$	Gate–Body Leakage	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$			$\pm 100$	nA
<b>On Characteristics (Note 2)</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1\text{ mA}$	1	1.4	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 10\text{ mA}$ , Referenced to $25^\circ\text{C}$		-0.3		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain–Source On–Resistance	$V_{GS} = 10\text{ V}, I_D = 13.5\text{ A}$ $V_{GS} = 4.5\text{ V}, I_D = 12\text{ A}$ $V_{GS} = 10\text{ V}, I_D = 13.5\text{ A}, T_J = 125^\circ\text{C}$		4.6 5.7 5.9	5.6 7.1 7.4	m $\Omega$
$I_{D(on)}$	On–State Drain Current	$V_{GS} = 10\text{ V}, V_{DS} = 5\text{ V}$	60			A
$g_{FS}$	Forward Transconductance	$V_{DS} = 5\text{ V}, I_D = 13.5\text{ A}$		61		S
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 15\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$		1960		pF
$C_{oss}$	Output Capacitance			570		pF
$C_{rss}$	Reverse Transfer Capacitance			210		pF
$R_G$	Gate Resistance	$V_{GS} = 15\text{ mV}, I_D = 6\text{ A}$		1.4		W
<b>Switching Characteristics (Note 2)</b>						
$t_{d(on)}$	Turn–On Delay Time	$V_{DS} = 15\text{ V}, I_D = 1\text{ A},$ $V_{GS} = 10\text{ V}, R_{GEN} = 6\ \Omega$		9	18	nS
$t_r$	Turn–On Rise Time			12	22	nS
$t_{d(off)}$	Turn–Off Delay Time			39	62	nS
$t_f$	Turn–Off Fall Time			18	33	nS
$Q_g(TOT)$	Total Gate Charge, $V_{gs} = 10\text{ V}$	$V_{DS} = 15\text{ V}, I_D = 13.5\text{ A}$		36	51	nC
$Q_g$	Total Gate Charge, $V_{gs} = 5\text{ V}$			20	28	nC
$Q_{gs}$	Gate–Source Charge			5		nC
$Q_{gd}$	Gate–Drain Charge			6		nC
<b>Drain–Source Diode Characteristics</b>						
$V_{SD}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 3.2\text{ A}$ (Note 1)		0.4	0.7	V
$t_{rr}$	Diode Reverse Recovery Time	$I_F = 13.5\text{ A}, d_{IF}/d_t = 300\text{ A}/\mu\text{s}$		23		nS
$Q_{rr}$	Diode Reverse Recovery Charge	See Diode Characteristic, page 5		21		nC

Notes:

- $R_{\theta JA}$  is determined with the device mounted on a  $1\text{ in}^2$  2 oz. copper pad on a  $1.5 \times 1.5\text{ in.}$  board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball,  $R_{\theta JB}$ , is defined for reference. For  $R_{\theta JC}$ , the thermal reference point for the case is defined as the top surface of the copper chip carrier.  $R_{\theta JC}$  and  $R_{\theta JB}$  are guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a)  $56^\circ\text{C/W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper



b)  $119^\circ\text{C/W}$  when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper

- Pulse Test: Pulse Width <  $300\ \mu\text{s}$ , Duty Cycle < 2.0%

## Typical Characteristics

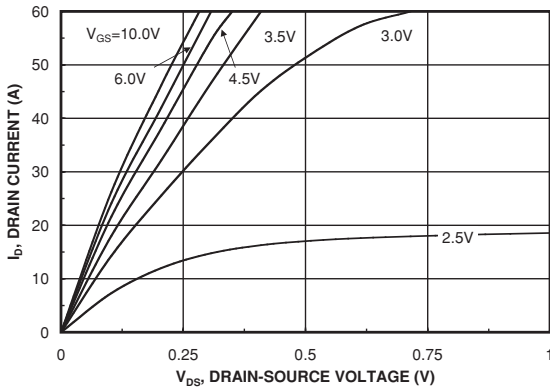


Figure 1. On-Region Characteristics.

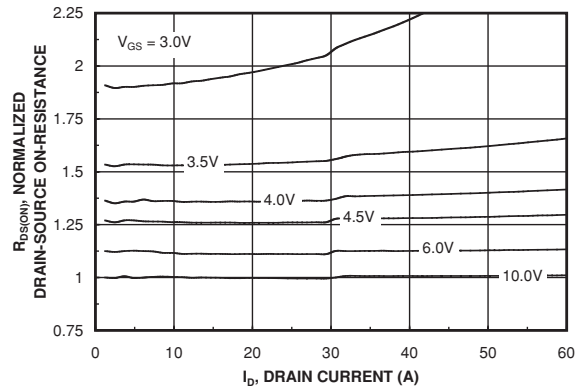


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

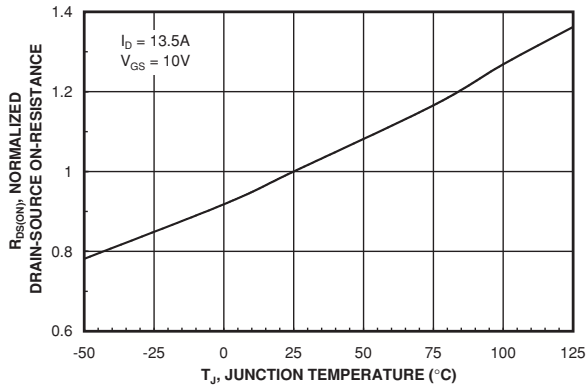


Figure 3. On-Resistance Variation with Temperature.

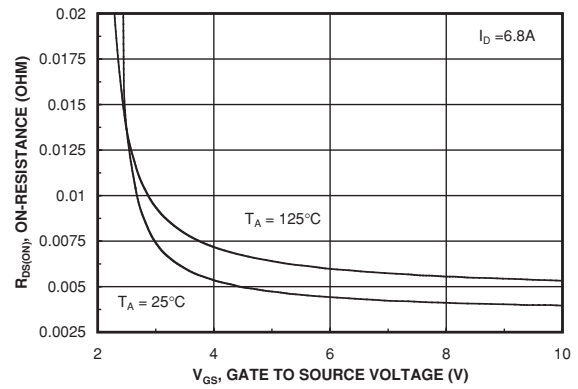


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

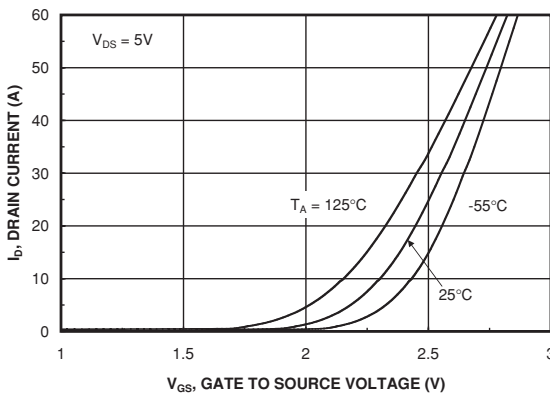


Figure 5. Transfer Characteristics.

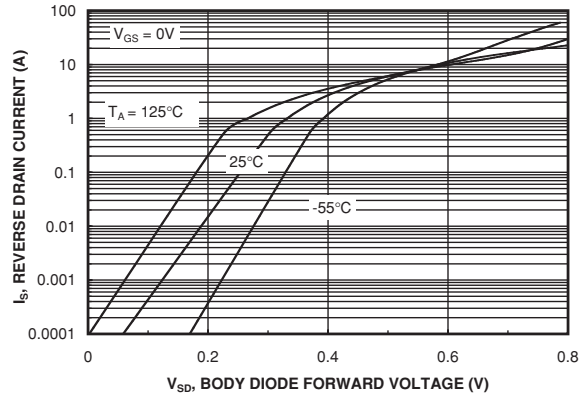


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics

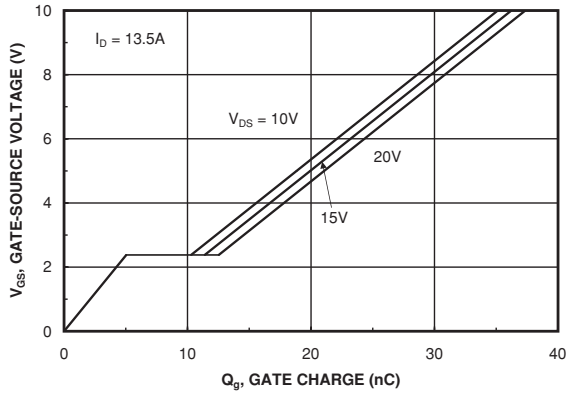


Figure 7. Gate Charge Characteristics.

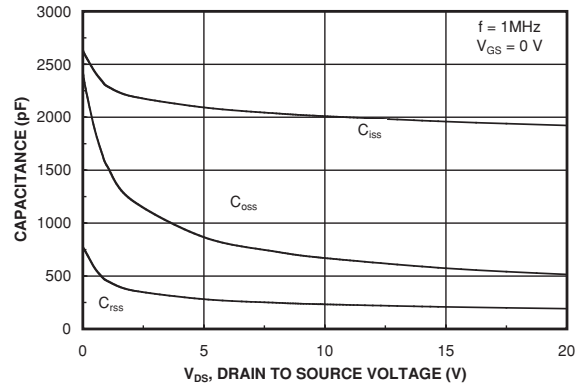


Figure 8. Capacitance Characteristics.

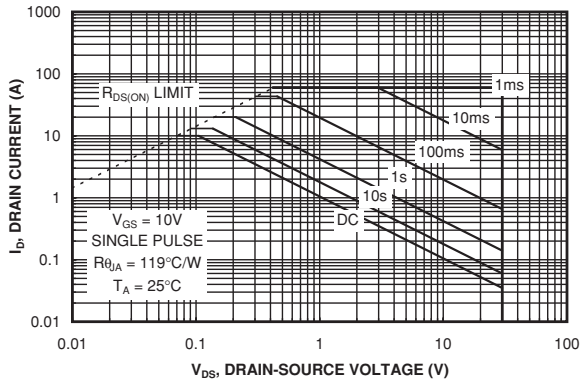


Figure 9. Maximum Safe Operating Area.

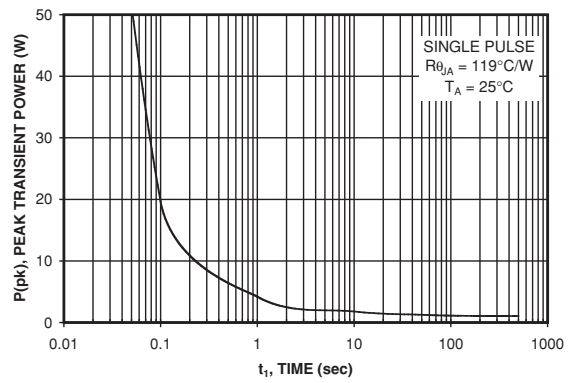


Figure 10. Single Pulse Maximum Power Dissipation.

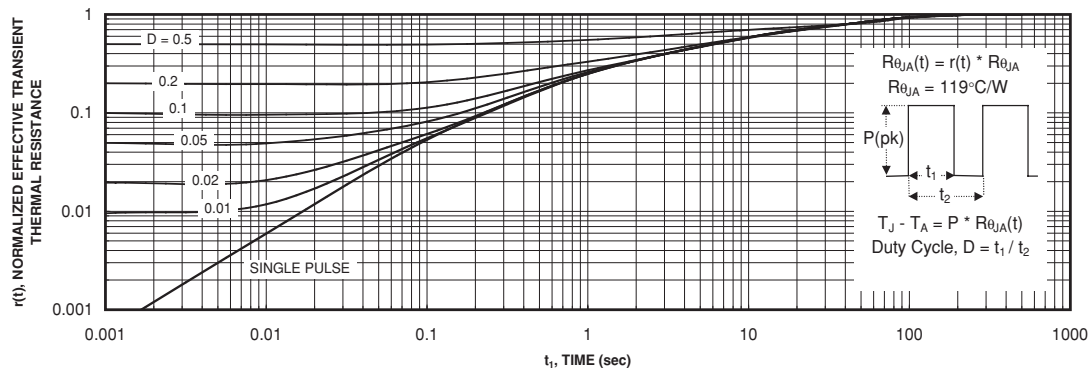


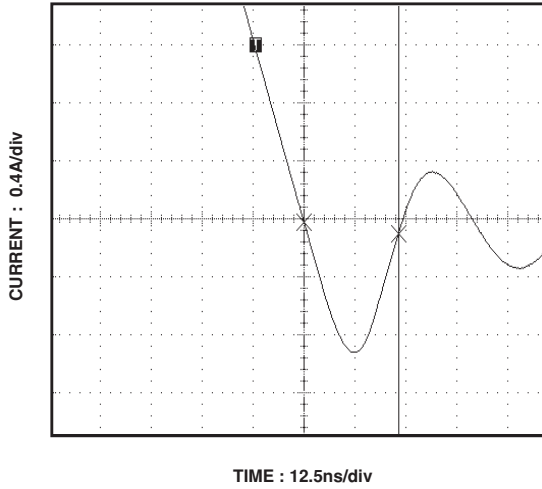
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

## Typical Characteristics

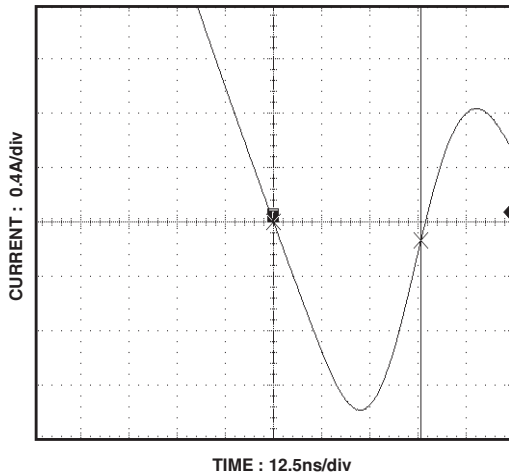
### SyncFET Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 FDZ7064AS.



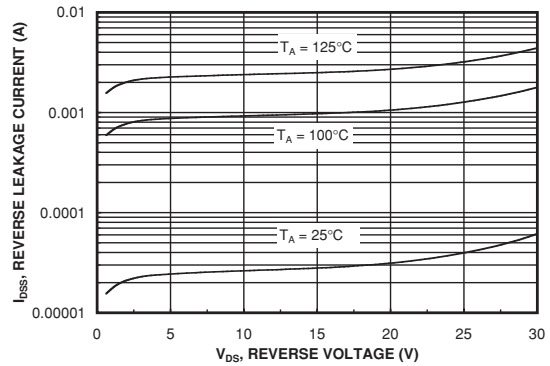
**Figure 12. FDZ7064AS SyncFET body diode reverse recovery characteristic.**

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET.



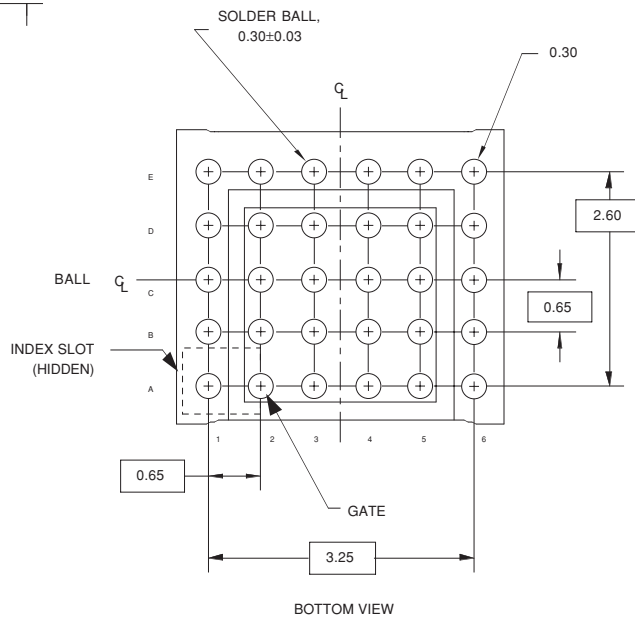
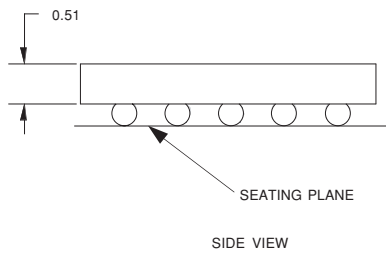
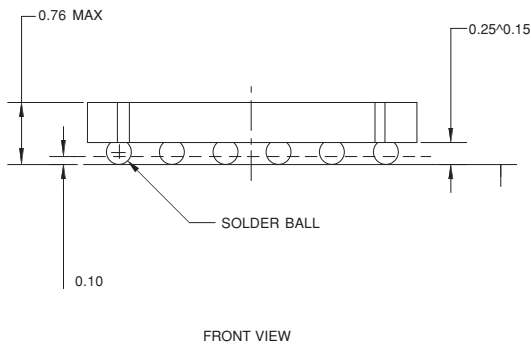
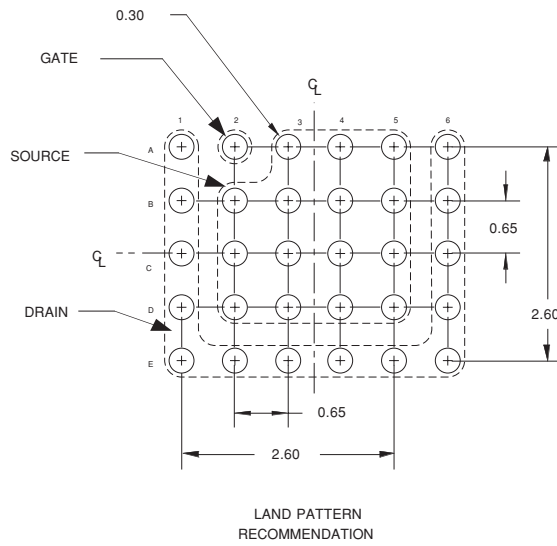
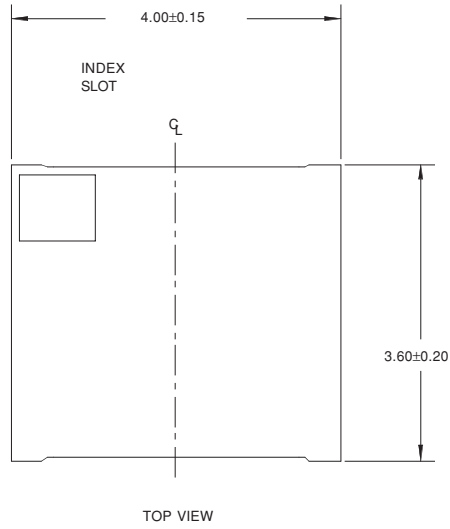
**Figure 13. Non-SyncFET (FDZ7064N) body diode reverse recovery characteristic.**

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.



**Figure 14. SyncFET diode reverse leakage versus drain-source voltage and temperature.**

## Dimensional Outline and Pad Layout



NOTES: UNLESS OTHERWISE SPECIFIED  
 A) ALL DIMENSIONS ARE IN MILLIMETERS.  
 B) NO JEDEC REGISTRATION REFERENCE AS OF JULY 1999.

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DOMET™	GTO™	MICROWIRE™	QS™	SyncFET™
EcoSPARK™	HiSeC™	MSX™	QT Optoelectronics™	TinyLogic®
E <sup>2</sup> C MOS™	PC™	MSXPro™	Quiet Series™	TINYOPTO™
EnSigna™	i-Lo™	OCX™	RapidConfigure™	TruTranslation™
FACT™	ImpliedDisconnect™	OCXPro™	RapidConnect™	UHC™
FACT Quiet Series™		OPTOLOGIC®	μSerDes™	UltraFET®
Across the board. Around the world.™		OPTOPLANAR™	SILENT SWITCHER®	UniFET™
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